Application/Control No. Applicant(s)/Patent Under Reexamination 09/957,401 NEUHAUS ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Alexander O Williams 2826 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 428/346 09-2002 Pfaff US-6447898B1 Α Wack 340/572.7 US-6229445B1 05-2001 В Paik et al. 524/739 08-2002 US-2002/0111423A1 С 252/512 05-2001 Yim et al. บ US-6238597B1 361/737 12-2002 Credelle et al. US-2002/0181208A1 Ε 439/886 US-5660570 08-1997 Chan et al. F 11-2001 Vogel et al. 361/704 US-6317326B1 G 347/171 06-2002 Novak et al. US-2002/0071020A1/ Н 324/757 US-2001/0033179A1 10-2001 Difrancesco US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х